# imall

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



## Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832 Email & Skype: info@chipsmall.com Web: www.chipsmall.com Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China







## 74AUP1G32

#### SINGLE 2 INPUT POSITIVE OR GATE

## Description

The Advanced Ultra Low Power (AUP) CMOS logic family is designed for low power and extended battery life in portable applications.

The 74AUP1G32 is a single, two-input, positive OR gate with a standard push-pull output designed for operation over a power supply range of 0.8V to 3.6V. The device is fully specified for partial power down applications using  $I_{OFF}$ . The  $I_{OFF}$  circuitry disables the output, preventing damaging current backflow when the device is powered down.

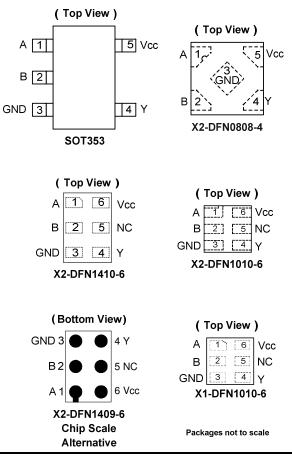
The gate performs the positive Boolean function:

 $Y = A + B \text{ or } Y = \overline{\overline{A} \bullet \overline{B}}$ 

## Features

- Advanced Ultra Low Power (AUP) CMOS
- Supply Voltage Range from 0.8V to 3.6V
- ±4mA Output Drive at 3.0V
- Low Static Power Consumption  $Icc < 0.9 \mu A$
- Low Dynamic Power Consumption C<sub>PD</sub> = 6.3pF (Typical at 3.6V)
- Schmitt Trigger Action at all inputs makes the circuit tolerant for slower input rise and fall time. The hysteresis is typically 250mV at V<sub>CC</sub> = 3.0V.
- IOFF Supports Partial-Power-Down Mode Operation
- ESD Protection Exceeds JESD 22
  2000-V Human Body Model (A114)
  Exceeds 1000-V Charged Device Model (C101)
- Latch-Up Exceeds 100mA per JESD 78, Class I
- Leadless Packages Named per JESD30E
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

## **Pin Assignments**



#### Applications

- Suited for Battery and Low Power Needs
- Wide Array of Products Such As:
  - Tablets, E-readers
  - Cell Phones, Personal Navigation / GPS
  - MP3 Players, Cameras, Video Recorders
  - PCs, Ultrabooks, Notebooks, Netbooks
  - Computer Peripherals, Hard Drives, SSDs, CD/DVD ROMs
  - TVs, DVDs, DVRs, Set-Top Boxes

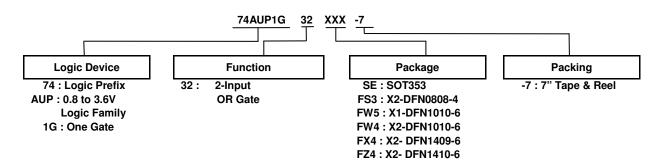
Notes: 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.

2. See http://www.diodes.com/quality/lead\_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.

3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.



## Ordering Information



Device	Package	Package	Package	7" Tape	and Reel
Device	Code	(Notes 4 & 5)	Size	Quantity	Part Number Suffix
74AUP1G32SE-7	SE	SOT353	2.0mm x 2.0mm x 1.1mm 0.65 mm lead pitch	3,000/Tape & Reel	-7
74AUP1G32FS3-7	FS3	X2-DFN0808-4	0.8mm x 0.8mm x 0.35mm 0.5 mm pad pitch (diamond)	5,000/Tape & Reel	-7
74AUP1G32FW5-7	FW5	X1-DFN1010-6	1.0mm x 1.0mm x 0.5mm 0.35 mm pad pitch	5,000/Tape & Reel	-7
74AUP1G32FW4-7	FW4	X2-DFN1010-6	1.0mm x 1.0mm x 0.4mm 0.35 mm pad pitch	5,000/Tape & Reel	-7
74AUP1G32FX4-7	FX4	X2-DFN1409-6 Chip Scale Alternative	1.4mm x 0.9mm x 0.4mm 0.5 mm pad pitch	5,000/Tape & Reel	-7
74AUP1G32FZ4-7	FZ4	X2-DFN1410-6	1.4mm x 1.0mm x 0.4mm 0.5 mm pad pitch	5,000/Tape & Reel	-7

Notes: 4. Pad layout as shown on Diodes Inc. suggested pad layout document AP02001, which can be found on our website at

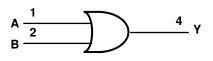
http://www.diodes.com/datasheets/ap02001.pdf.

5. The taping orientation is located on our website at http://www.diodes.com/datasheets/ap02007.pdf.

## **Pin Descriptions**

Pin Name	Function
A	Data Input
В	Data Input
GND	Ground
Y	Data Output
V <sub>CC</sub>	Supply Voltage

## Logic Diagram



## **Function Table**

Inp	uts	Output
Α	В	Y
L	L	L
L	Н	Н
Н	L	Н
Н	Н	Н



#### Absolute Maximum Ratings (Notes 6 & 7) (@T<sub>A</sub> = +25 °C, unless otherwise specified.)

Symbol	Description	Rating	Unit
ESD HBM	Human Body Model ESD Protection	2	kV
ESD CDM	Charged Device Model ESD Protection	1	kV
V <sub>CC</sub>	Supply Voltage Range	-0.5 to +4.6	V
VI	Input Voltage Range	-0.5 to +4.6	V
Vo	Voltage Applied to Output in High or Low State	-0.5 to V <sub>CC</sub> +0.5	V
lıĸ	Input Clamp Current (VI < 0)	50	mA
Ι <sub>ΟΚ</sub>	Output Clamp Current (V <sub>O</sub> < 0)	50	mA
Ι <sub>Ο</sub>	Continuous Output Current ( $V_O = 0$ to $V_{CC}$ )	±20	mA
Icc	Continuous Current Through V <sub>CC</sub>	50	mA
IGND	Continuous Current Through GND	-50	mA
TJ	Operating Junction Temperature	-40 to +150	°C
T <sub>STG</sub>	Storage Temperature	-65 to +150	°C

Notes: 6. Stresses beyond the absolute maximum may result in immediate failure or reduced reliability. These are stress values and device operation should be within recommend values.

7. Forcing the maximum allowed voltage could cause a condition exceeding the maximum current or conversely forcing the maximum current could cause a condition exceeding the maximum voltage. The ratings of both current and voltage must be maintained within the controlled range.

## Recommended Operating Conditions (Note 8) (@T<sub>A</sub> = +25 °C, unless otherwise specified.)

Symbol	Par	ameter	Min	Max	Unit
Vcc	Operating Voltage		0.8	3.6	V
VI	Input Voltage		0	3.6	V
Vo	Output Voltage		0	Vcc	V
		$V_{CC} = 0.8V$	—	-20	μA
		$V_{CC} = 1.1 V$	_	-1.1	
I <sub>OH</sub> High-Level Output C	Link Lough Output Output	$V_{CC} = 1.4V$	_	-1.7	
	High-Level Output Current	V <sub>CC</sub> = 1.65V	_	-1.9	mA
		V <sub>CC</sub> = 2.3V	_	-3.1	
		$V_{CC} = 3.0 V$	—	-4	
		$V_{CC} = 0.8V$	_	20	μA
		V <sub>CC</sub> = 1.1V	_	1.1	
		$V_{CC} = 1.4V$	_	1.7	
I <sub>OL</sub>	Low-Level Output Current	V <sub>CC</sub> = 1.65V	—	1.9	mA
		V <sub>CC</sub> = 2.3V	_	3.1	
		V <sub>CC</sub> = 3.0V	—	4	1
Δt/ΔV	Input Transition Rise or Fall Rate V <sub>CC</sub> = 0.8V to 3.6V		—	200	ns/V
T <sub>A</sub>	Operating Free-Air Temperature	·	-40	+125	°C

Note: 8. Unused inputs should be held at  $V_{CC}$  or Ground.



## Electrical Characteristics (@T<sub>A</sub> = +25 °C, unless otherwise specified.)

Symbol	Parameter	Test Conditions	V <sub>CC</sub>	T <sub>A</sub> = -	+25 <i>°</i> C	T <sub>A</sub> = -40 °C	C to +85℃	Unit
Symbol	Farameter	Test Conditions	V CC	Min	Max	Min	Max	Unit
		—	0.8V to 1.65V	$0.80 \times V_{CC}$	—	$0.80 \times V_{CC}$	—	
VIH	High-Level Input	—	1.65V to 1.95V	$0.65 \times V_{CC}$	—	$0.65 \times V_{CC}$	—	v
VIН	Voltage	_	2.3V to 2.7V	1.6	—	1.6		v
			3.0V to 3.6V	2.0	_	2.0	—	
		—	0.8V to 1.65V		$0.30 \times V_{CC}$	—	$0.30 \times V_{CC}$	
VIL	Low-Level Input	—	1.65V to 1.95V	—	$0.35 \times V_{CC}$	—	$0.35 \times V_{\text{CC}}$	v
VIL	Voltage		2.3V to 2.7V		0.7	—	0.7	v
		—	3.0V to 3.6V		0.9	_	0.9	
		I <sub>OH</sub> = -20μA	0.8V to 3.6V	V <sub>CC</sub> -0.1	—	V <sub>CC</sub> -0.1	_	
		I <sub>OH</sub> = -1.1mA	1.1V	$0.75 \times V_{CC}$	—	$0.7 \times V_{CC}$	—	
		I <sub>OH</sub> = -1.7mA	1.4V	1.11	_	1.03	_	
V	High-Level	I <sub>OH</sub> = -1.9mA	1.65V	1.32	—	1.3	_	v
V <sub>OH</sub>	Output Voltage	I <sub>OH</sub> = -2.3mA	- 2.3V	2.05	—	1.97	—	v
		I <sub>OH</sub> = -3.1mA	2.3V	1.9	—	1.85	—	
		I <sub>OH</sub> = -2.7mA	- 3V	2.72	—	2.67	—	
		I <sub>OH</sub> = -4mA	3V	2.6	—	2.55	_	
		I <sub>OL</sub> = 20μA	0.8V to 3.6V	—	0.1	—	0.1	
		I <sub>OL</sub> = 1.1mA	1.1V	—	0.3 x V <sub>CC</sub>	—	$0.3 \times V_{CC}$	
		I <sub>OL</sub> = 1.7mA	1.4V	_	0.31	—	0.37	
	Low-Level	I <sub>OL</sub> = 1.9mA	1.65V	_	0.31	—	0.35	v
V <sub>OL</sub>	Output Voltage	I <sub>OL</sub> = 2.3mA	0.01/	_	0.31	—	0.33	v
		I <sub>OL</sub> = 3.1mA	2.3V	_	0.44	_	0.45	
		I <sub>OL</sub> = 2.7mA	01/	_	0.31	—	0.33	
		I <sub>OL</sub> = 4mA	- 3V	_	0.44	—	0.45	
h	Input Current	A or B Input VI = GND to 3.6V	0V to 3.6V	- 1	±0.1	—	±0.5	μA
I <sub>OFF</sub>	Power Down Leakage Current	$V_{\rm I}$ or $V_{\rm O} = 0$ V to 3.6V	0	_	0.2	_	0.6	μA
Δl <sub>OFF</sub>	Delta Power Down Leakage Current	$V_{\rm I}$ or $V_{\rm O}$ = 0V to 3.6V	0V to 0.2V	_	0.2		0.6	μA
Icc	Supply Current	$V_I = GND \text{ or } V_{CC}, I_O = 0$	0.8V to 3.6V	—	0.5	_	0.9	μA
ΔI <sub>CC</sub>	Additional Supply Current	One Input at $V_{CC}$ -0.6V Other Inputs at $V_{CC}$ or GND	3.3V	_	40	—	50	μA



## Electrical Characteristics (continued) (@T<sub>A</sub> = +25 °C, unless otherwise specified.)

Cumula al	Devenuetov	Test Canditions	N/	T <sub>A</sub> = -40 °C	C to +125℃	11
Symbol	Parameter	Test Conditions	V <sub>cc</sub>	Min	Max	Unit
		—	0.8V to 1.65V	0.80 x V <sub>CC</sub>	—	
VIH	High-Level Input	_	1.65V to 1.95V	0.70 x V <sub>CC</sub>	—	v
VIH	Voltage		2.3V to 2.7V	1.6	—	v
			3.0V to 3.6V	2.0	—	
			0.8V to 1.65V	—	0.25 x V <sub>CC</sub>	
V <sub>IL</sub>	Low-Level Input	_	1.65V to 1.95V	—	0.30 x V <sub>CC</sub>	v
۷IL	Voltage		2.3V to 2.7V	—	0.7	v
			3.0V to 3.6V	—	0.9	
		I <sub>OH</sub> = -20µА	0.8V to 3.6V	V <sub>CC</sub> -0.11	—	
		I <sub>OH</sub> = -1.1mA	1.1V	0.6 x V <sub>CC</sub>	_	
		I <sub>OH</sub> = -1.7mA	1.4V	0.93	—	
., <i>,</i>	High-Level	I <sub>OH</sub> = -1.9mA	1.65V	1.17	—	
VOH	Output Voltage	I <sub>OH</sub> = -2.3mA	0.01/	1.77	—	V
		I <sub>OH</sub> = -3.1mA	2.3V	1.67	_	
		I <sub>OH</sub> = -2.7mA	01/	2.40	_	
		I <sub>OH</sub> = -4mA	- 3V	2.30	_	
		I <sub>OL</sub> = 20μΑ	0.8V to 3.6V	_	0.11	
		$I_{OL} = 1.1 \text{mA}$	1.1V	_	0.33 x V <sub>CC</sub>	
		I <sub>OL</sub> = 1.7mA	1.4V	—	0.41	
	Low-Level	I <sub>OL</sub> = 1.9mA	1.65V	—	0.39	1
V <sub>OL</sub>	Output Voltage	I <sub>OL</sub> = 2.3mA		_	0.36	- V
		I <sub>OL</sub> = 3.1mA	2.3V	_	0.50	
		I <sub>OL</sub> = 2.7mA		_	0.36	
		I <sub>OL</sub> = 4mA	- 3V	_	0.50	
I <sub>I</sub>	Input Current	A or B Input VI = GND to 3.6V	0V to 3.6V	—	±0.75	μA
IOFF	Power Down Leakage Current	$V_{I}$ or $V_{O} = 0V$ to 3.6V	0	_	±3.5	μΑ
ΔI <sub>OFF</sub>	Delta Power Down Leakage Current	$V_1 \text{ or } V_0 = 0 \text{V to } 3.6 \text{V}$	0V to 0.2V	_	±2.5	μΑ
Icc	Supply Current	$V_I = GND \text{ or } V_{CC}, I_O = 0$	0.8V to 3.6V	—	3.0	μA
Δlcc	Additional Supply Current	Input at $V_{CC}$ -0.6V Other Inputs at $V_{CC}$ or GND	3.3V	_	75	μΑ



## **Switching Characteristics**

Parameter From Input	From	То	Vcc	Т	A = +25 ۹	С	T <sub>A</sub> = -40 °C	T <sub>A</sub> = -40 ℃ to +85 ℃		to +125℃	Unit
	Output	V CC	Min	Тур	Max	Min	Max	Min	Max	Unit	
		or B V	0.8V		16.8	—	_	_	—	_	
			1.2V ± 0.1V	2.2	5.1	10.9	2.1	11.9	2.1	13.2	-
	A or D		1.5V ± 0.1V	1.6	3.6	6.6	1.4	7.5	1.4	8.3	
t <sub>pd</sub> A or B	Ŷ	1.8V ± 0.15V	1.4	3.0	5.2	1.2	6.0	1.2	6.6	ns	
			2.5V ± 0.2V	1.1	2.4	3.9	1.0	4.6	1.0	5.1	
		•	3.3V ± 0.3V	1.0	2.1	3.5	0.9	4.1	0.9	4.6	

#### CL=10pF, See Figure 1

Parameter	From Input	To Output	Vcc	T <sub>A</sub> = +25 ℃			T <sub>A</sub> = -40 ℃ to +85 ℃		T <sub>A</sub> = -40 ℃ to +125 ℃		Unit
			V CC	Min	Тур	Max	Min	Max	Min	Max	onnt
			0.8V	_	20.3	—	—	—	_	_	
		Y	1.2V ± 0.1V	2.3	5.9	12.7	2.1	13.8	2.1	15.2	ns
	A or B		1.5V ± 0.1V	1.9	4.2	7.7	1.7	8.7	1.7	9.6	
t <sub>pd</sub>	AUD		1.8V ± 0.15V	1.7	3.5	6.0	1.5	6.9	1.5	7.7	
			2.5V ± 0.2V	1.4	2.9	4.6	1.3	5.5	1.3	6.1	
			3.3V ± 0.3V	1.3	2.7	4.3	1.2	5.0	1.2	5.5	

#### CL=15pF See, Figure 1

Parameter	From Input	To Output	V <sub>cc</sub>	Т	T <sub>A</sub> = +25 ℃		T <sub>A</sub> = -40 ℃ to +85 ℃		T <sub>A</sub> = -40 ℃ to +125 ℃		Unit
Farameter				Min	Тур	Max	Min	Max	Min	Max	onne
			0.8V	_	23.8	_	—	—	_	—	
			1.2V ± 0.1V	3.3	6.7	16.3	3.0	19.9	3.0	19.9	ns
	A or B	V	1.5V ± 0.1V	2.3	4.8	8.6	2.0	9.8	2.0	10.8	
t <sub>pd</sub>	AUD	ř	1.8V ± 0.15V	2.0	4.0	6.7	1.8	7.9	1.8	8.7	
		2.5V ± 0.2V	1.7	3.3	5.3	1.6	6.3	1.6	6.9		
			$3.3V \pm 0.3V$	1.5	3.1	4.9	1.5	5.8	1.5	6.4	

#### CL=30pF, See Figure 1

Parameter	From Input	To Output	Vcc	T <sub>A</sub> = +25 ℃			T <sub>A</sub> = -40 ℃ to +85 ℃		T <sub>A</sub> = -40 ℃ to +125 ℃		Unit
Falailletei			V CC	Min	Тур	Max	Min	Max	Min	Max	Onit
			0.8V		34.1	—		—			
		Y	1.2V ± 0.1V	4.5	15.0	19.1	4.0	23.5	4.0	23.7	ns
	A or B		1.5V ± 0.1V	3.4	6.3	11.3	2.9	13.3	2.9	14.7	
t <sub>pd</sub>	AUD		1.8V ± 0.15V	2.6	5.3	8.9	2.4	10.7	2.4	11.8	
			2.5V ± 0.2V	2.3	4.4	7.0	2.2	8.4	2.2	9.3	
			3.3V ± 0.3V	2.0	3.2	6.4	2.0	7.7	2.0	8.5	



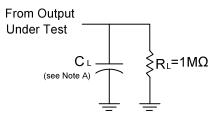
## Operating and Package Characteristics (@T<sub>A</sub> = +25 °C, unless otherwise specified.)

	Parameter	Test Conditio		Vcc	Тур	Unit
				0.8V	6.9	
				1.2V ± 0.1V	6.8	
0	Power Dissipation	f = 1MH	lz	1.5V ± 0.1V	6.7	~_
CPD	Capacitance	No Loa	d	1.8V ± 0.15V	6.6	pF
				2.5V ± 0.2V	6.4	
				3.3V ± 0.3V	6.3	
CI	Input Capacitance	VI = V <sub>CC</sub> or	GND	0V or 3.3V	1.5	pF
		SOT353		1	371	
		X2-DFN0808-4		_	430	
•	Thermal Resistance	X1-DFN1010-6		_	435	~~~~
$\theta_{JA}$	Junction-to-Ambient	X2-DFN1010-6	(Note 9)		445	°C/W
		X2-DFN1409-6		1	470	
		X2-DFN1410-6		1	460	
		SOT353		_	143	
		X2-DFN0808-4		_	240	
0	Thermal Resistance	X1-DFN1010-6	(Nata 0)	_	250	
AlC	θ <sub>JC</sub> Junction-to-Case	X2-DFN1010-6	(Note 9)	_	250	°C/W
		X2-DFN1409-6		_	275	1
		X2-DFN1410-6		_	265	1

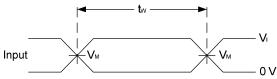
Note: 9. Test condition for each of the six package types: Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.



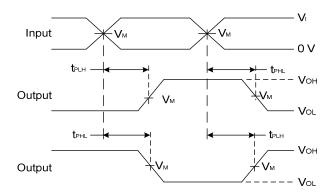
## **Parameter Measurement Information**



Vee	Inputs		N.	0
Vcc	VI	t <sub>r</sub> /t <sub>f</sub>	V <sub>M</sub>	CL
0.8V	V <sub>CC</sub>	≤3ns	V <sub>CC</sub> /2	5, 10, 15, 30pF
1.2V±0.1V	V <sub>CC</sub>	≤3ns	V <sub>CC</sub> /2	5, 10, 15, 30pF
1.5V±0.1V	V <sub>CC</sub>	≤3ns	V <sub>CC</sub> /2	5, 10, 15, 30pF
1.8V ±0.15V	V <sub>CC</sub>	≤3ns	V <sub>CC</sub> /2	5, 10, 15, 30pF
2.5V±0.2V	V <sub>CC</sub>	≤3ns	V <sub>CC</sub> /2	5, 10, 15, 30pF
3.3V±0.3V	V <sub>CC</sub>	≤3ns	V <sub>CC</sub> /2	5, 10, 15, 30pF



**Voltage Waveform Pulse Duration** 



**Voltage Waveform Propagation Delay Times** Inverting and Non Inverting Outputs

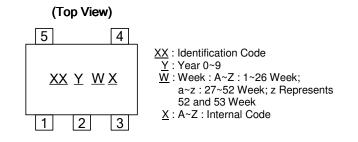
Figure 1 Load Circuit and Voltage Waveforms

- Notes:
- A. Includes test lead and test apparatus capacitance. B. All pulses are supplied at pulse repetition rate  $\leq$  10MHz.
  - C. Inputs are measured separately one transition per measurement.
  - D. t<sub>PLH</sub> and t<sub>PHL</sub> are the same as t<sub>PD.</sub>



## **Marking Information**

(1) SOT353



Part Number	Package	Identification Code	
74AUP1G32SE-7	SOT353	XU	

(2) X2-DFN0808-4, X1-DFN1010-6, X2-DFN1010-6, X2-DFN1409-6 and X2-DFN1410-6

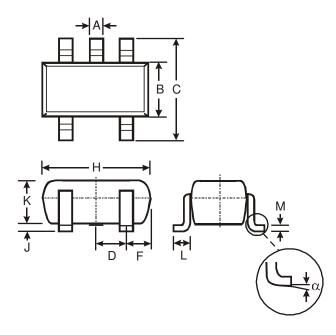
## (Top View)

<u>×x</u> • <u>Y W X</u>  $\label{eq:X} \begin{array}{l} \underline{XX}: \mbox{ Identification Code} \\ \underline{Y}: \mbox{ Year } 0~9 \\ \underline{W}: \mbox{ Week : } A~Z: 1~26 \mbox{ Week;} \\ a~z: 27~52 \mbox{ Week; } z \mbox{ Represents} \\ 52 \mbox{ and } 53 \mbox{ Week} \\ \underline{X}: \mbox{ A~Z : Internal Code} \end{array}$ 

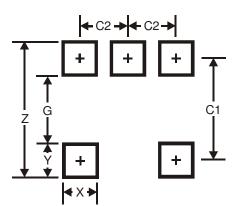
Part Number	Package	Identification Code
74AUP1G32FS3-7	X2-DFN0808-4	YW
74AUP1G32FW5-7	X1-DFN1010-6	QU
74AUP1G32FW4-7	X2-DFN1010-6	XU
74AUP1G32FX4-7	X2-DFN1409-6	HK
74AUP1G32FZ4-7	X2-DFN1410-6	XU



## SOT353 Package Outline Dimensions and Suggested Pad Layout



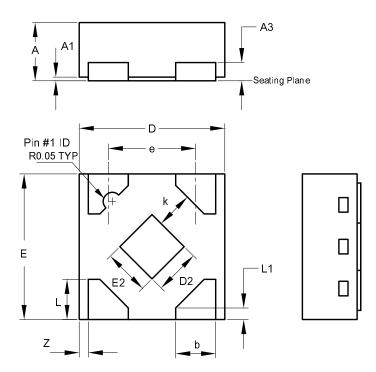
	SOT353					
Dim	Min	Max	Тур			
Α	0.10	0.30	0.25			
В	1.15	1.35	1.30			
С	2.00	2.20	2.10			
D		0.65 Typ	0			
F	0.40	0.45	0.425			
н	1.80	2.20	2.15			
J	0	0.10	0.05			
К	0.90	1.00	1.00			
L	0.25	0.40	0.30			
М	0.10	0.22	0.11			
α	0°	8°	-			
A	All Dimensions in mm					



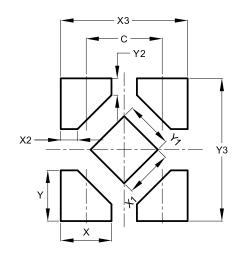
Dimensions	Value (in mm)
Z	2.5
G	1.3
Х	0.42
Y	0.6
C1	1.9
C2	0.65



## X2-DFN0808-4 Package Outline Dimensions and Suggested Pad Layout



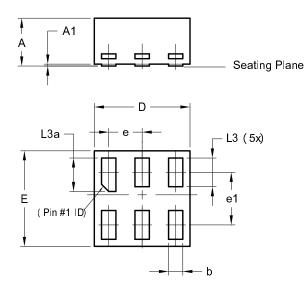
	X2-DFN0808-4					
Dim	Min	Max	Тур			
Α	0.25	0.35	0.30			
A1	0	0.04	0.02			
A3	-	-	0.13			
b	0.17	0.27	0.22			
D	0.75	0.85	0.80			
D2	0.15	0.35	0.25			
Е	0.75	0.85	0.80			
E2	0.15	0.35	0.25			
е	-	-	0.48			
К	0.20	-	-			
L	0.17	0.27	0.22			
L1	0.02	0.12	0.07			
Z	-	-	0.05			
All	All Dimensions in mm					



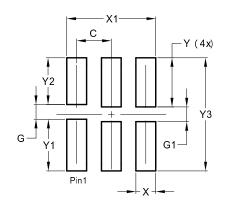
Dimensions	Value
С	0.480
Х	0.320
X1	0.300
X2	0.106
X3	0.800
Y	0.320
Y1	0.300
Y2	0.106
Y3	0.900



## X1-DFN1010-6 (Type B) Package Outline Dimensions and Suggested Pad Layout



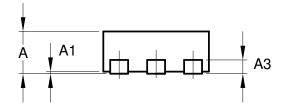
X1-DFN1010-6						
	(Type B)					
Dim	Min	Max	Тур			
Α	-	0.50	0.39			
A1	-	0.04	-			
b	0.12	0.20	0.15			
D	0.95	1.050	1.00			
E	0.95	1.050	1.00			
е	e 0.35 BSC					
e1		0.55 B	SC			
L3	0.27	0.30	0.30			
L3a	0.32	0.40	0.35			
All	All Dimensions in mm					

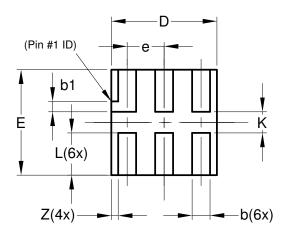


Dimensions	Value
Dimensions	(in mm)
С	0.350
G	0.150
G1	0.150
Х	0.200
X1	0.900
Y	0.500
Y1	0.525
Y2	0.475
Y3	1.150

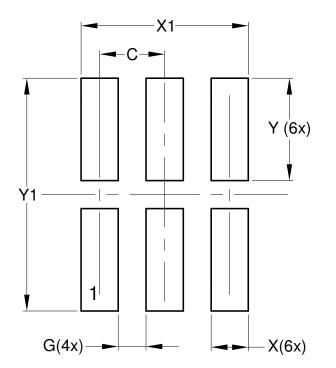


## X2-DFN1010-6 Package Outline Dimensions and Suggested Pad Layout





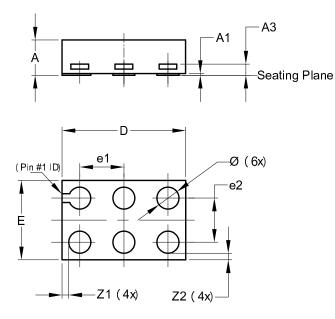
)	X2-DFN1010-6				
Dim	Min	Max	Тур		
Α		0.40	0.39		
A1	0.00	0.05	0.02		
A3			0.13		
b	0.14	0.20	0.17		
b1	0.05	0.15	0.10		
D	0.95	1.05	1.00		
Е	0.95	1.05	1.00		
е			0.35		
L	0.35	0.45	0.40		
к	0.15				
Z			0.065		
All D	All Dimensions in mm				



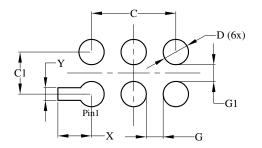
Dimensions	Value (in mm)
С	0.350
G	0.150
X	0.200
X1	0.900
Y	0.550
Y1	1.250



## X2-DFN1409-6 Package Outline Dimensions and Suggested Pad Layout



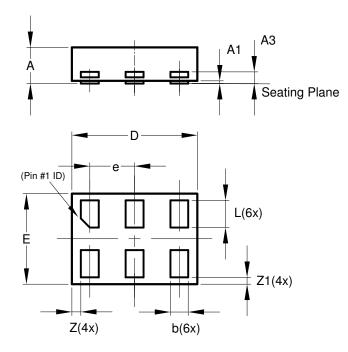
	X2-DFN1409-6				
Dim	Min	Max	Тур		
Α	-	0.40	0.39		
A1	0	0.05	0.02		
A3	-	-	0.13		
Ø	0.20	0.30	0.25		
D	1.35	1.45	1.40		
Е	0.85	0.95	0.90		
e1	-	-	0.50		
e2	-	-	0.50		
Z1	-	-	0.075		
Z2	-	-	0.075		
All C	All Dimensions in mm				



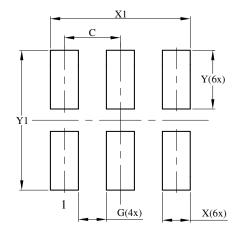
Dimensions	Value (in mm)
С	1.000
C1	0.500
D	0.300
G	0.200
G1	0.200
Х	0.400
Y	0.150



## X2-DFN1410-6 Package Outline Dimensions and Suggested Pad Layout



X2-DFN1410-6				
Dim	Min	Max	Тур	
Α	_	0.40	0.39	
A1	0.00	0.05	0.02	
A3			0.13	
b	0.15	0.25	0.20	
D	1.35	1.45	1.40	
E	0.95	1.05	1.00	
е	_	_	0.50	
L	0.25	0.35	0.30	
Z	_	_	0.10	
Z1	0.045	0.105	0.075	
All Dimensions in mm				



Dimensions	Value (in mm)
С	0.500
G	0.250
X	0.250
X1	1.250
Y	0.525
Y1	1.250



#### **IMPORTANT NOTICE**

DIODES INCORPORATED MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARDS TO THIS DOCUMENT, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION).

Diodes Incorporated and its subsidiaries reserve the right to make modifications, enhancements, improvements, corrections or other changes without further notice to this document and any product described herein. Diodes Incorporated does not assume any liability arising out of the application or use of this document or any product described herein; neither does Diodes Incorporated convey any license under its patent or trademark rights, nor the rights of others. Any Customer or user of this document or products described herein in such applications shall assume all risks of such use and will agree to hold Diodes Incorporated and all the companies whose products are represented on Diodes Incorporated website, harmless against all damages.

Diodes Incorporated does not warrant or accept any liability whatsoever in respect of any products purchased through unauthorized sales channel. Should Customers purchase or use Diodes Incorporated products for any unintended or unauthorized application, Customers shall indemnify and hold Diodes Incorporated and its representatives harmless against all claims, damages, expenses, and attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized application.

Products described herein may be covered by one or more United States, international or foreign patents pending. Product names and markings noted herein may also be covered by one or more United States, international or foreign trademarks.

This document is written in English but may be translated into multiple languages for reference. Only the English version of this document is the final and determinative format released by Diodes Incorporated.

#### LIFE SUPPORT

Diodes Incorporated products are specifically not authorized for use as critical components in life support devices or systems without the express written approval of the Chief Executive Officer of Diodes Incorporated. As used herein:

- A. Life support devices or systems are devices or systems which:
  - 1. are intended to implant into the body, or
  - 2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.
- B. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or to affect its safety or effectiveness.

Customers represent that they have all necessary expertise in the safety and regulatory ramifications of their life support devices or systems, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of Diodes Incorporated products in such safety-critical, life support devices or systems, notwithstanding any devices- or systems-related information or support that may be provided by Diodes Incorporated. Further, Customers must fully indemnify Diodes Incorporated and its representatives against any damages arising out of the use of Diodes Incorporated products in such safety-critical, life support devices or systems.

Copyright © 2015, Diodes Incorporated

www.diodes.com